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Ge	5,926,515	07/20/1999	Park		375	376	
col	5,355,098	10/11/1994	Iwasaki		331	14	
Cal	4,677,394	06/30/1987	Volimer		331	IA	
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ATTY. DOCKET NO. APPLN. SERIAL NO. P-0646 New U.S. Patent LIST OF PRIOR ART CITED BY **Application APPLICANT** APPLICANT(S) Jong-Hyuk BAEK (PTO-1449) **CUSTOMER NO. 34610** FILING DATE GROUP February 23, 2004 To be assigned U.S. PATENT DOCUMENTS **EXAMINER'S** *ISSUE FILING DATE INITIALS *PATENT NO. DATE *INVENTOR NAME CLASS SUBCLASS 33 6,404,292 06/11/2002 LAUTZENHISER TUS PATENT APPLICATION BUBLICATIONS *PATENT APPLN. PUB. NO. *PUB. *APPLICANT CLASS SUBCLASS DATE U.S. PATENT APPLICATIONS *APPLN. *FILING NO. DATE *INVENTOR CLASS SUBCLASS FOREIGN PATENTIDOCUMENTS **EXAMINER'S** Translation INITIALS PATENT NO. DATE COUNTRY CLASS **SUBCLASS** Yes No WO 01/61857 A2 08/23/2001 PCT 2002-111492 04/12/2002 **JAPAN** Abstract EP 1 223 676 A2 07/17/2002 **EUROPE** 2002-0066925 08/21/2002 KOREA -X- OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.) **EXAMINER** DATE CONSIDERED 31,7005